

Flatness, roughness, and discrete defect characterization for computer disks, wafers, and flat panel displays - 8-9 August 1996, Denver, Colorado

SPIE-The International Society for Optical Engineering - Vol 9 (3ed) Asnt Handbook (vt) [34wm2jveeyl7]

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[chopra I., Sirohi J.] Smart Structures Theory [30j719meg50w]

The process changes due to work material variation chip formation and the changes in machining forces that result, or burr formation and the resulting dimensional error, are two examples are very difficult to quantify. .

Air force sbir 07 1 proposal submission instructions

When dependencies are unknown, global optimization over boxes is the only way to obtain a meaningful result when enclosures are necessary. Taking calibrations of Ti diffusion in orthopyroxene and of Cr-diffusion in olivine the time scale for the partial melting is estimated on the order of years to hundreds of years if alteration under constant temperature is assumed.

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